

UNITED STATES
PATENT AND TRADEMARK OFFICE



17th Annual Berkeley - Stanford Advanced Patent Law Institute

Perspectives from the USPTO

December 9th, 2016

John Cabeca

*West Coast Regional Director
United States Patent and Trademark Office*

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Agenda

- 2016 Year in Review
- Enhancing Patent Quality
- Subject Matter Eligibility
- Open Data Portal



FY 2016 Patent Filings



608,555 Utility, Plant & Reissue

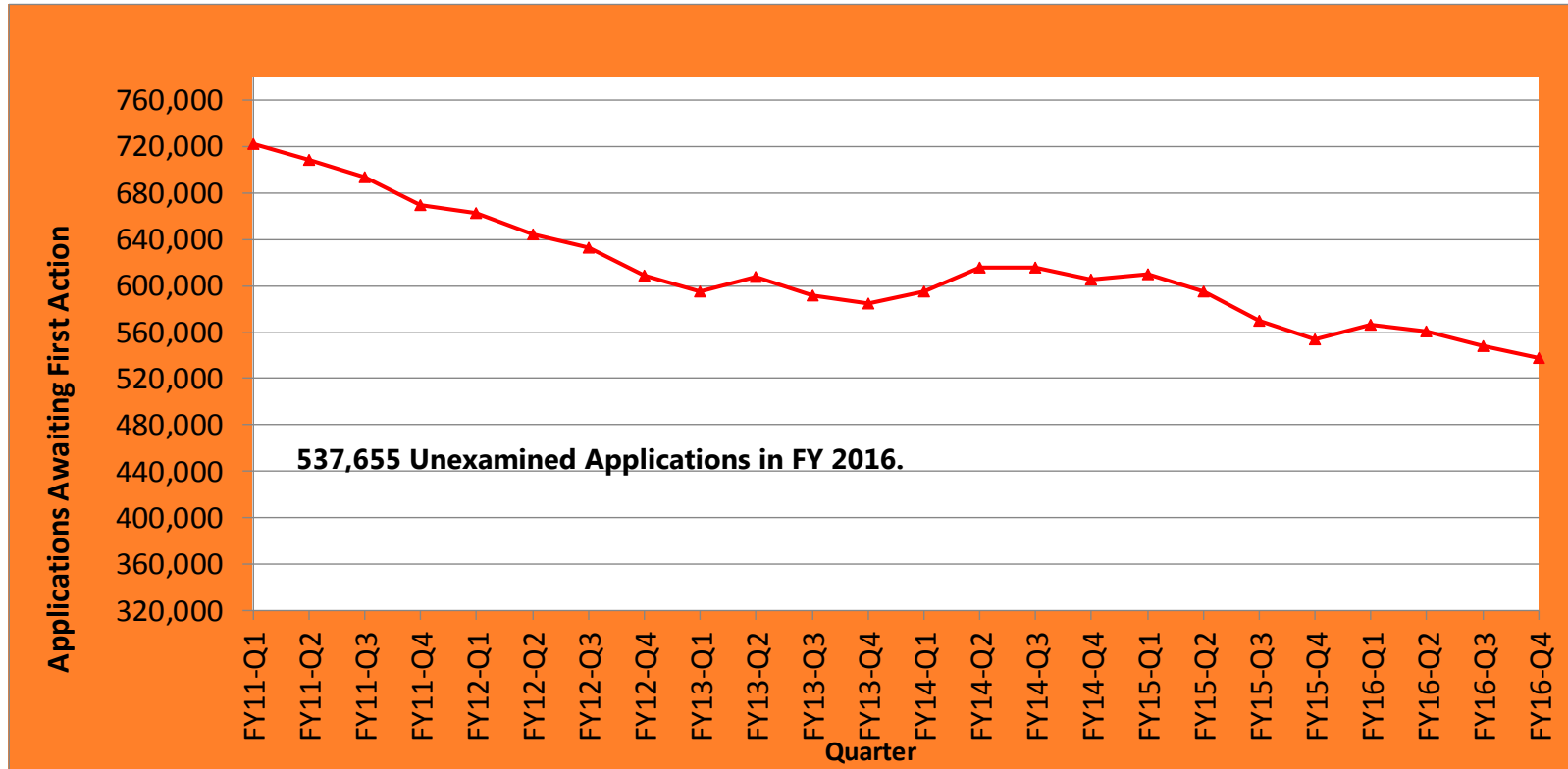
+ **5.1%** over FY 2015

+ **1.6%** Serialized over FY 2015

75% Large 21.8% Small 3.2% Micro

Unexamined Patent Application Inventory

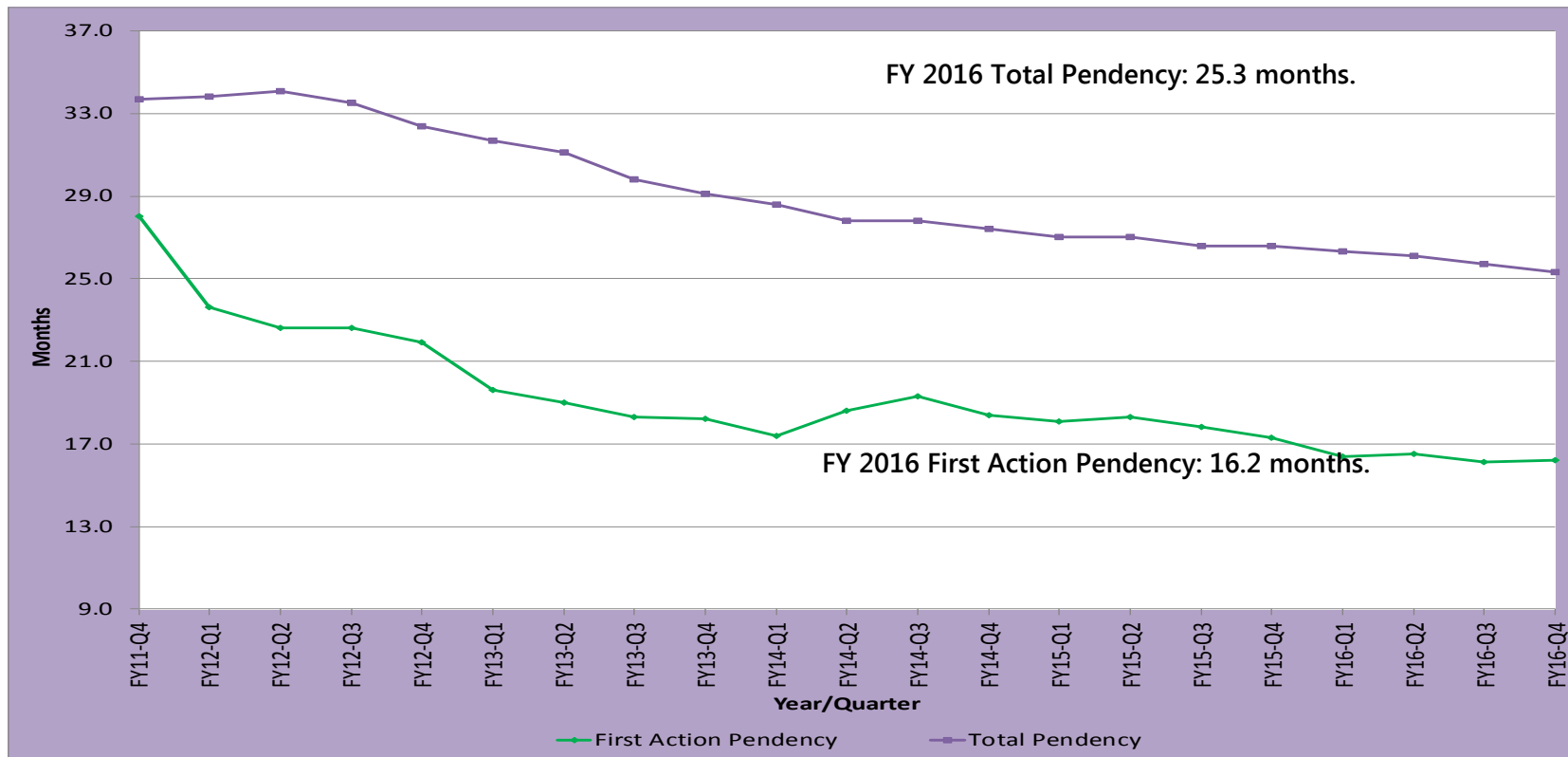
FY 2011 – FY 2016



FY 2015 Result: 553,221.

First Action Pendency and Total Pendency

FY 2011 – FY 2016



Enhancing Patent Quality

Update on Pilots and Initiatives

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Patent Quality Pillars



Pillar 1 – Excellence in Work Products



Pillar 2 – Excellent in Measuring Patent Quality



Pillar 3 – Excellence in Customer Service

EPQI Programs

Focused on three implementation areas:



Data Analysis

Pillar 1

- **Topic Submission for Case Studies**

Pillar 2

- **Clarity and Correctness Data Capture (Master Review Form or MRF)**
- **Quality Metrics**

Examiners' Resources, Tools & Training

Pillar 1

- **Automated Pre-Examination Search Pilot**
- **STIC Awareness Campaign**
- **Improving Clarity and Reasoning in Office Actions Training (ICR Training)**
- **Post Grant Outcomes**

Pillar 3

- **Interview Specialist**

Changes to Process/Product

Pillar 1

- **Clarity of the Record Pilot**

Pillar 3

- **Post-Prosecution Pilot (P3)**
- **Reevaluate QPIDS**
- **Design Patent Publication Quality**

Quality Metrics Redefined

FY 2011 – FY 2015

Final Disposition Compliance

In-Process Compliance

First Action (FAOM) Review

Search Review

Quality Index Reporting (QIR)

External Quality Survey

Internal Quality Survey

Composite Score

Moving Forward

Product Indicators

Master Review Form

Capturing both correctness and clarity of examiners' final work product using uniform criteria gathered in a single database

Process Indicators

Transactional QIR

Tracking the efficiency and consistency of our processes (for example, to identify "churning")

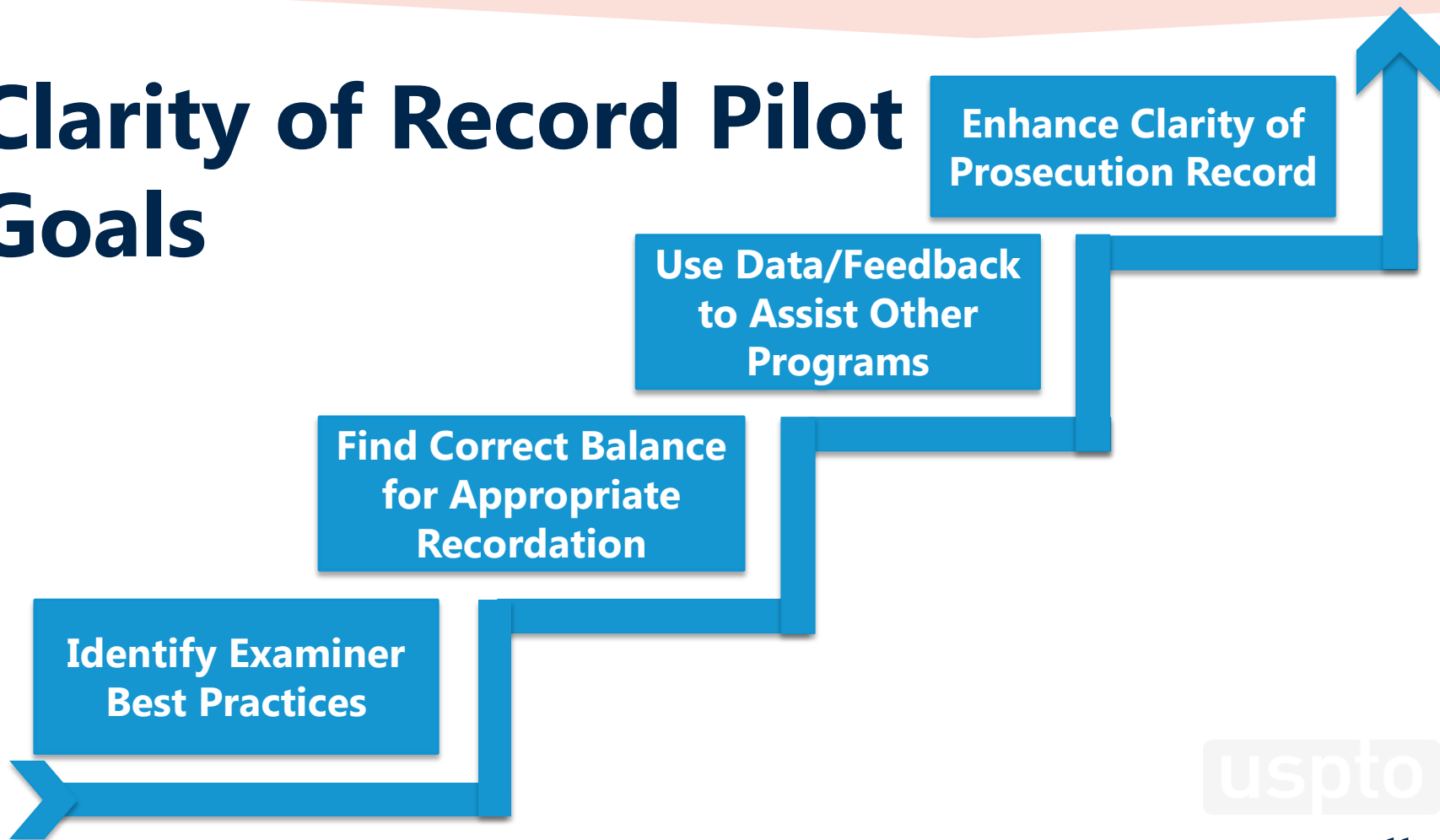
Perception Indicators

Survey Results

Continuing to internally and externally poll perceptions of patent quality

Composite Score

Clarity of Record Pilot Goals



Clarity of Record Pilot - Areas of Focus

- More detailed interview summaries
- Enhanced documentation of claim interpretation

➤ Special definitions of claim terms	➤ Optional language
➤ Functional language	➤ Non-functional descriptive material
➤ Intended use or result (preamble and body of claim)	➤ Computer-implemented functions that invoke 35 U.S.C. §112(f) ("specialized" or "non-specialized")
➤ "Means-plus-function" (35 U.S.C. §112(f))	

- More precise reasons for allowance
- Pre-search interview - Examiner's option

Improving Clarity and Reasoning Training

**35 U.S.C. 112(f):
Identifying Limitations
that Invoke § 112(f)**

**35 U.S.C. 112(f):
Making the Record
Clear**

**35 U.S.C. 112(f):
Broadest Reasonable
Interpretation and
Definiteness of § 112(f)
Limitations**

**35 U.S.C. 112(f):
Evaluating Limitations
in Software-Related
Claims for Definiteness
under 35 U.S.C. 112(b)**

**Broadest Reasonable
Interpretation (BRI)
and the Plain Meaning
of Claim Terms**

**Examining Functional
Claim Limitations:
Focus on
Computer/Software-
related Claims**

**Examining Claims for
Compliance with 35
U.S.C. 112(a): Part I
Written Description**

**Examining Claims for
Compliance with 35
U.S.C. 112(a): Part II –
Enablement**

**35 U.S.C. 112(a):
Written Description
Workshop**

**§ 112(b): Enhancing
Clarity By Ensuring
That Claims Are
Definite Under 35
U.S.C. 112(b)**

**2014 Interim Guidance
on Patent Subject
Matter Eligibility**

**Abstract Idea Example
Workshops I & II**

**Enhancing Clarity By
Ensuring Clear
Reasoning of
Allowance Under C.F.R.
1.104(e) and MPEP
1302.14**

**35 U.S.C. 101: Subject
Matter Eligibility
Workshop III: Formulating
a Rejection and Evaluating
the Applicant's Response**

**35 U.S.C. 112(b):
Interpreting Functional
Language and
Evaluating Claim
Boundaries - Workshop**

**Advanced Writing
Techniques utilizing
Case Law**



Stakeholder Training on Examination Practice and Procedure (STEPP)

- 3-Day training on examination practice and procedure for junior patent practitioners
- Provide external stakeholders with a better understanding of how and why an examiner makes decisions while examining a patent application
- Aid in compact prosecution by disclosing to external stakeholders how examiners are taught to use the MPEP to interpret an applicant's disclosure

STEPP Course Schedule

Description	Date(s)	Duration	Location
3-Day Training on Examination Practice and Procedure	November 15-17, 2016	3 Days	Alexandria, VA Campus
3-Day Training on Examination Practice and Procedure	January 10-12, 2017	3 Days	Dallas, TX – Texas Regional Office
3-Day Training on Examination Practice and Procedure	March 14-16, 2017	3 Days	San Jose, CA – Silicon Valley Regional Office
3-Day Training on Examination Practice and Procedure	May 9-11, 2017	3 Days	Denver, CO – Rocky Mountain Regional Office
3-Day Training on Examination Practice and Procedure	July 11-13, 2017	3 Days	Alexandria, VA Campus
3-Day Training on Examination Practice and Procedure	September 19-21, 2017	3 Days	Detroit, MI – Midwest Regional Office

Post Prosecution Pilot (P3) Pilot



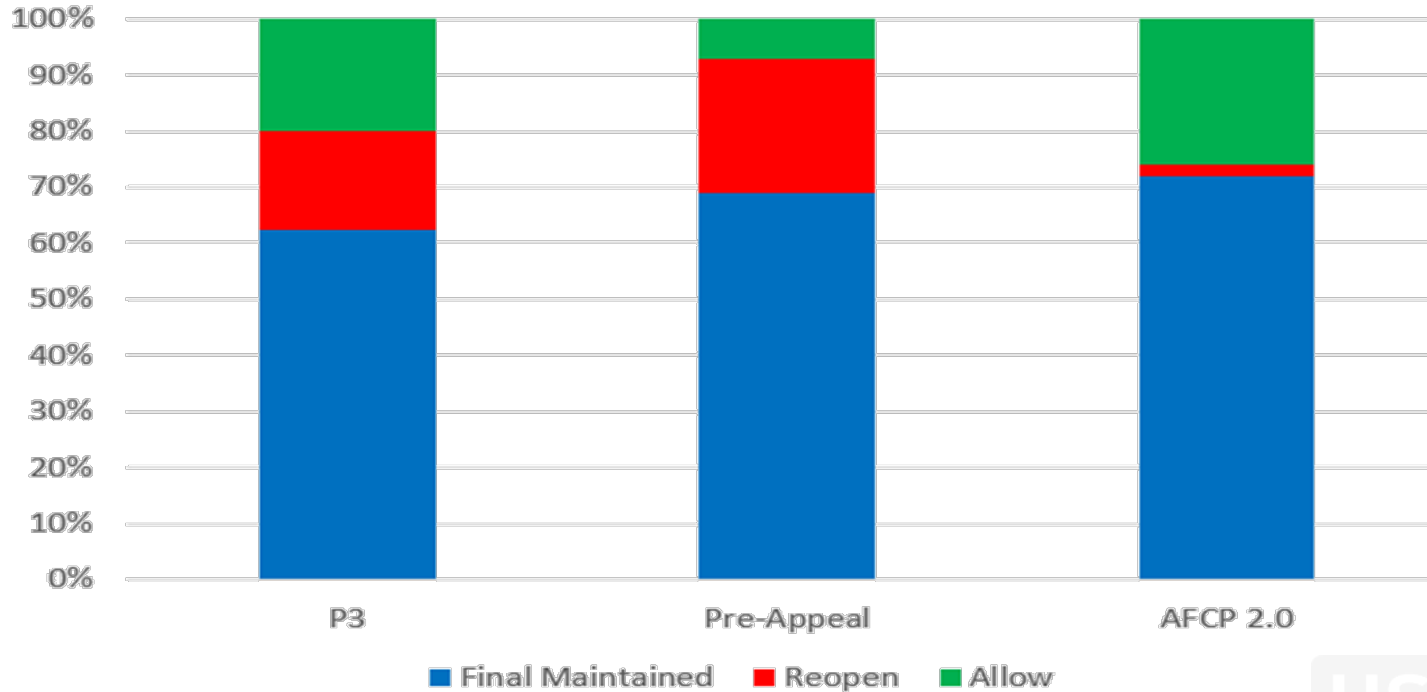
Post Prosecution Pilot – P3 (through Oct. 27, 2016)

Total Submissions	1222
Approved	1023
Defective	113
Conferences Held	614

Conference Outcomes	Count
Allowed	118
Final Maintained	368
Reopened	102
Awaiting Decision	588

P3 Outcomes

Program Outcomes – 10/24/16



AFCP 2.0 data is from start of program; Final Maintained is RCEs + Advisories
Pre-Appeal data is for FY15 + FY16

Post Grant Outcomes - Objectives

- **Purpose:** To learn from all post grant proceedings and inform examiners of their outcomes.

1. Enhanced Patentability Determinations in Related Child Cases

- Providing examiners with full access to trial proceedings submitted during PTAB post AIA Trials

2. Targeted Examiner Training

- Data collected from the prior art submitted and examiner behavior will provide a feedback loop on best practices

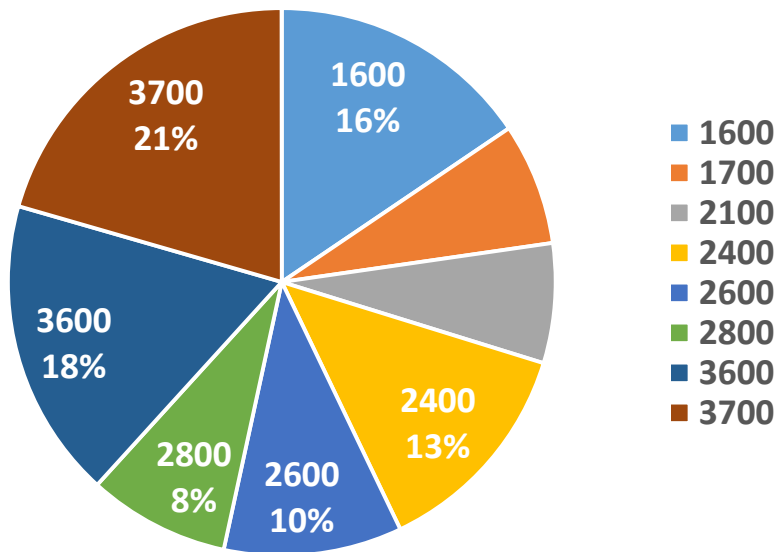
3. Examining Corps Education

- Provide examiners a periodic review of post grant outcomes focusing on technology sectors

Post Grant Outcomes

Pilot Statistics

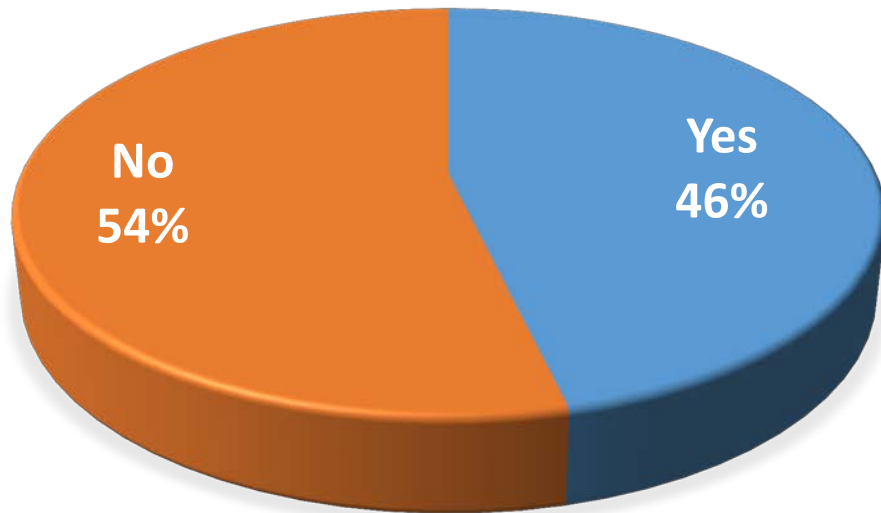
DISTRIBUTION OF PILOT APPLICATIONS
BY TECHNOLOGY CENTER



Technology Center	Number of Pilot Applications
1600	121
1700	56
2100	55
2400	102
2600	82
2800	65
3600	138
3700	160
Grand Total	779

Objective 1 – Pilot Statistics cont.

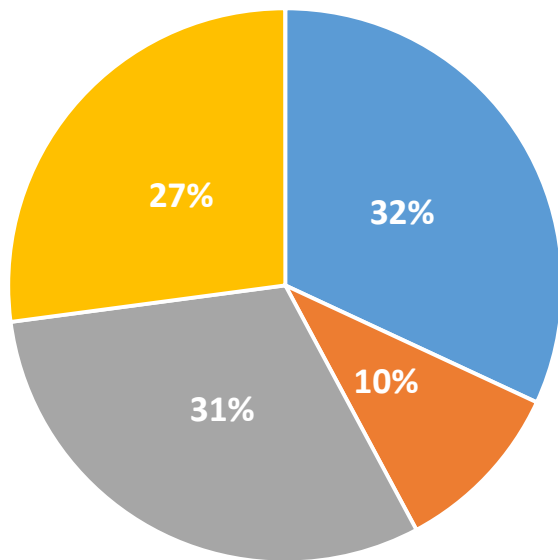
In the Office Action of the child case, did the examiner refer to any of the references cited in the AIA trial petition of the parent case?



Based on 270 Survey Responses

Pilot Statistics cont.

If the examiner did not use any references cited in the AIA Trial Petition, why?



- The claims in my pilot case were substantially different from the parent case.
- I disagreed with the petitioner's analysis of the prior art and/or claims.
- I was able to find better art on my own.
- Other



Based on 136 Survey Responses

1 Hour Ethics CLE available!

Patent Quality Conference

Advancing Patent Quality across the IP Community



Tuesday, Dec 13, 2016 | 8:30 a.m. – 5 p.m. EST
USPTO Headquarters – Madison Auditorium

Livestream: Silicon Valley USPTO – 9:00 a.m. to 5:30 p.m.

Presentations, Panel Discussions, and Insights into the Future of Patent Quality

Examination Time Analysis - Roundtables



For additional information and ways to provide feedback please see our website at <https://www.uspto.gov/patent/initiatives/eta-external-outreach>



Patent Subject Matter Eligibility Roundtable Wrap-Up

Public Comment Period Closes Soon!

USPTO seeks public input on patent subject matter eligibility in view of recent decisions by the Supreme Court of the United States. The roundtable focused on receiving feedback regarding larger questions concerning the legal contours of eligible subject matter in the U.S. patent system.

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Open Data Portal

developer.uspto.gov

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Open Data @USPTO

Become innovative.



Data can be beautiful.

[Our growing library of visualization »](#)



Share with us.

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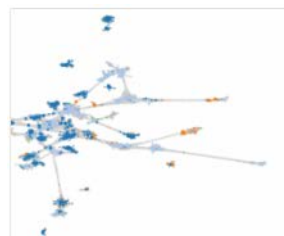
Explore our data.

[A catalog of our data products »](#)



Make something.

[Our library of APIs »](#)



Co-patenting Network of Top 100 Inventors in Cancer-Related Fields

Published September 14, 2016

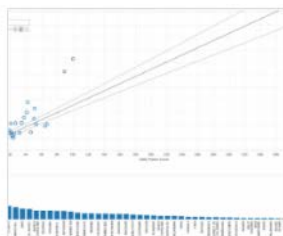
Cancer Moonshot



Worldwide Innovation in Cancer-Related Fields - Yearly Inventor Numbers and Patent Counts

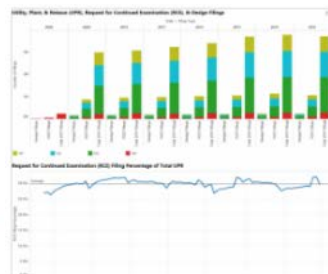
Published September 14, 2016

Cancer Moonshot



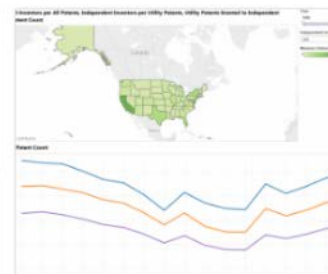
State GDP by Utility Patents

Published June 6, 2016



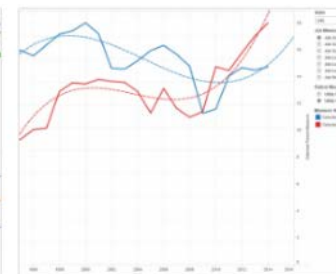
Patent Filing Data

Published June 6, 2016



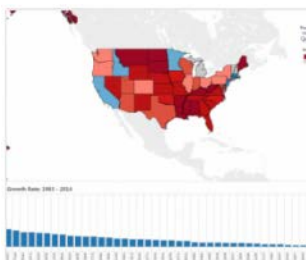
Independent Inventor Patent Count

Published June 6, 2016



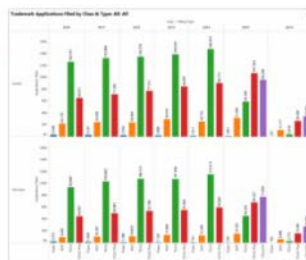
State Job Data Against Patents

Published April 25, 2016



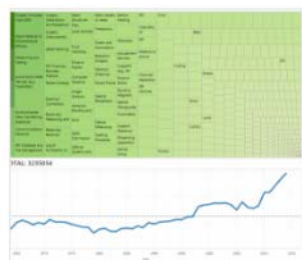
Utility Patents per State over Time

Published April 22, 2016



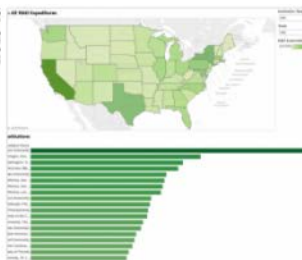
Trademark Application Filing Statistics

Published April 22, 2016



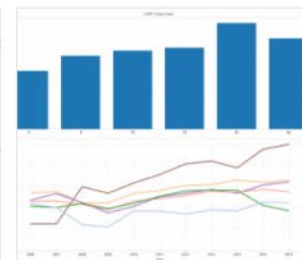
Technology Class Treemap by State

Published April 22, 2016



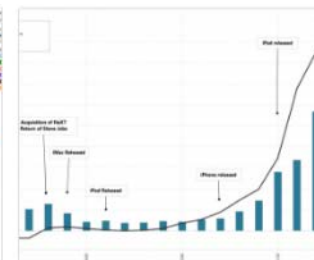
University Patent Count & Expenditures

Published April 22, 2016



Allowance Rate by USPC Class

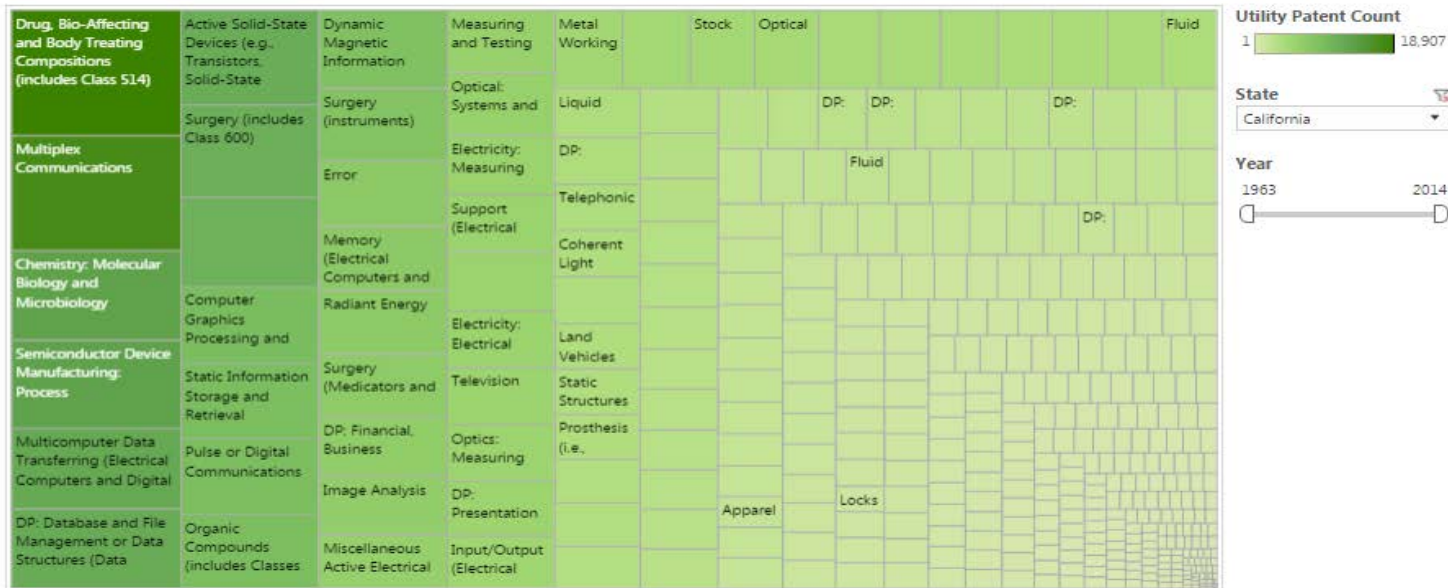
Published April 22, 2016



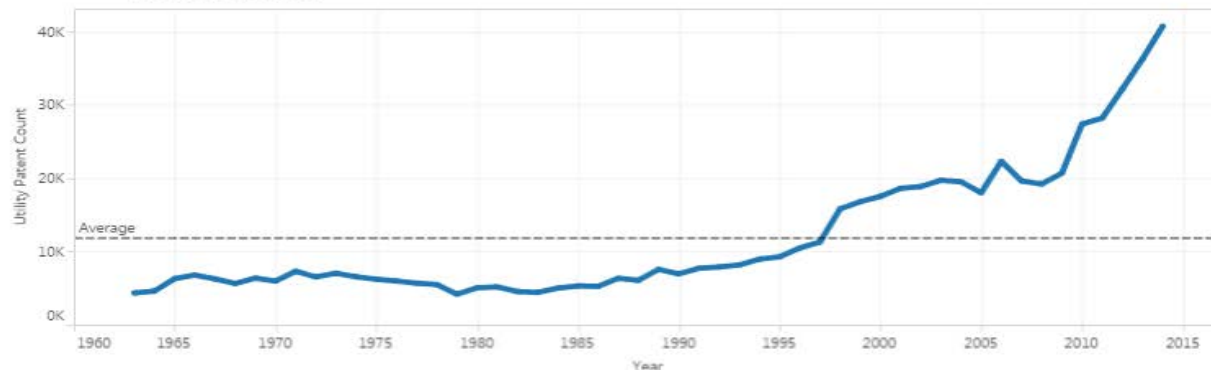
Apple Finances by Utility Patent Count

Published April 22, 2016

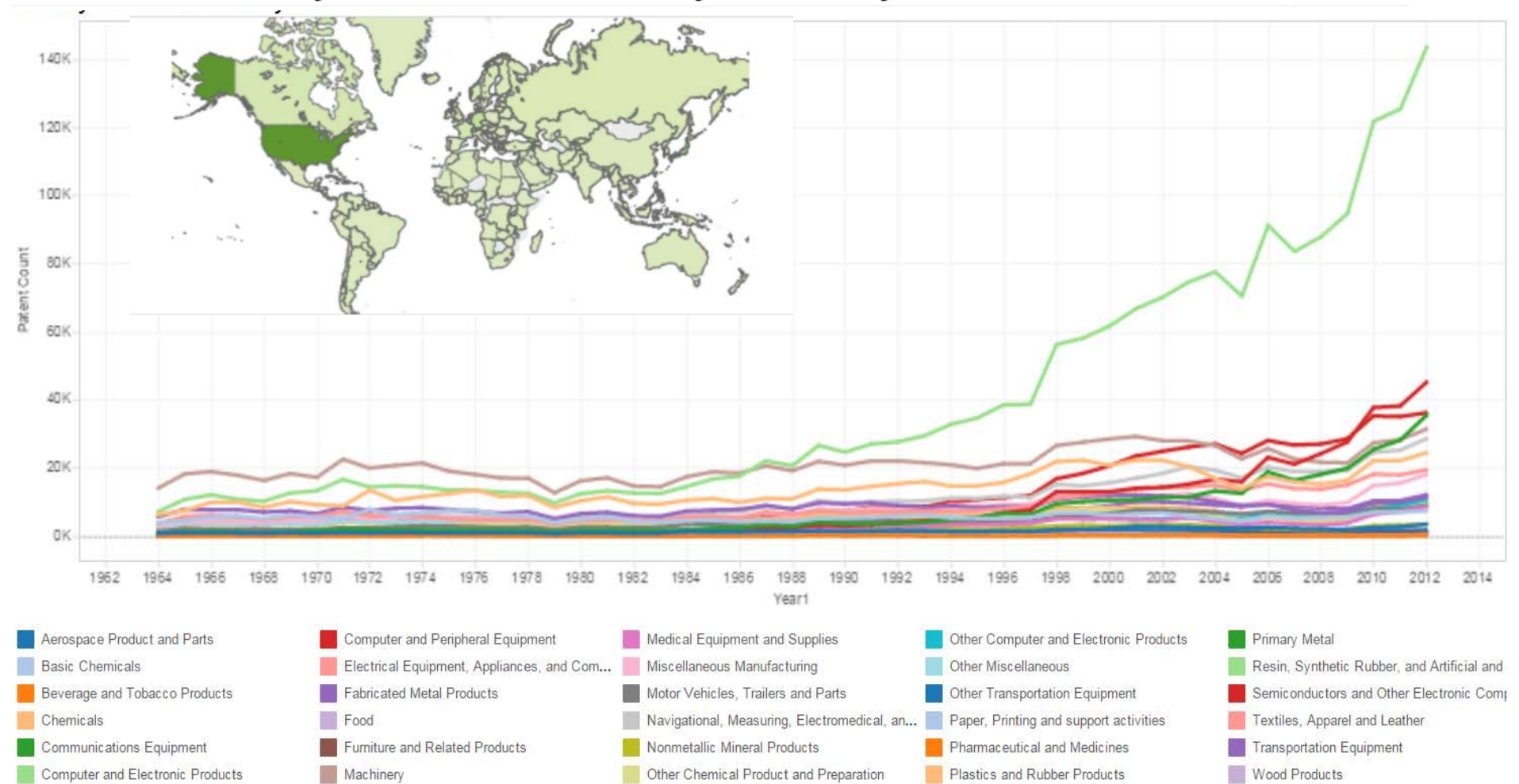
Technology Class Treemap by State



TOTAL: 617497



NAICS Industry Classifications by Country & State (2 visuals)



A detailed technical drawing of a mechanical assembly, likely a multi-layer printed circuit board (PCB) or a similar electronic component. The drawing is rendered in a light gray line-art style against a white background. It features numerous rectangular and circular components, some of which are labeled with numbers such as 18, 80, 40, 36, 22, 26, 68, 24, 30, 86, 34, 32, 52, 84, and 82. The components are interconnected by various lines and patterns, suggesting a complex assembly. The drawing is oriented horizontally and occupies the entire background of the slide.

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<http://www.youtube.com/user/USPTOvideo/>

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